Notice of References Cited

Application/Control No. | Applicant(s)/Patent Under Reexamination UMOTOY ET AL. |

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## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-4,392,299	07-1983	Shaw, Joseph M.	438/660
	В	US-4,817,557	04-1989	Diem et al.	118/719
	С	US-5,906,683	05-1999	Chen et al.	118/724
	D .	US-6,472,323 B1	10-2002	Meikle et al.	438/685
	E	US-6,572,706 B1	06-2003	Nguyen et al.	118/724
	F	US-2003/0019428 A1	01-2003	Ku et al.	118/715
	G	US-2003/0019580 A1	01-2003	Strang, Eric J.	156/345.33
	Н	US-2003/0116087 A1	06-2003	Nguyen et al.	118/715
	1	US-2003/0140857 A1	07-2003	Umotoy et al.	118/726
	J	US-			
	K	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	P.					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	>	
	8	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.